



TestForum 2010

Drammen, Norway
November 23rd & 24th, 2010

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Test Forum 2010 Local Organizer

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Partners of Nordic Test Forum



EXPERTKOMPETENS
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Call for Papers / Presentations

The 2-day TestForum 2010, the 11th event in the series, is a major event for Test professionals in the Nordic area and Baltic states. Every year the TestForum is attended by the industry's key persons as well as by international vendors of test and measurement equipment and solutions.

The event will take place in Drammen, Norway. Nordic Test Forum hereby cordially invites you to participate and submit your contribution to TestForum 2010, which includes (but is not limited to) the following topics:

- *Embedded Test*
- *Functional test*
- *AOI / AXI*
- *Test economics*
- *ICT / Flying Probe*
- *Boundary-Scan test*
- *Preventive test / Prognostics*
- *Best practices in manufacturing test*
- *ASIC: BIST / Mixed-signal / IDDQ / IDDT*
- *Board test SW, BIST, diagnostics*
- *Testing Lead Free Electronics*
- *Design to Test transfer / Design for Testing*
- *Quality methods and tools*
- *ESD*
- *Test efficiency and optimization*
- *Future technology trends and test challenges*
- *Data acquisition / collection / analysis*

Submissions

NTF seeks for full papers and/or presentations in the area of test of electronics, including *R&D, Application Contributions, Best Practices, Emerging Ideas*, etc. You are free to submit contributions outside the above topics as long as they stay within the field of electronics test. Focus shall be on new and upcoming challenges, opportunities and techniques rather than on particular products.

Proceedings

At the event, Nordic Test Forum will deliver on electronic format the accepted contributions of authors that wish to provide the corresponding materials.

The Format of the Event

- The event duration will be a two-day workshop and a small exhibition attached to it.
- November 22nd on the evening there is the AGM of the NTF.
- The mix of presentations will decide the number of sessions.
- The presentations will be 30 minutes each: 25 minutes of speech and 5 minutes for questions and comments.
- During the exhibition, attendees will have a chance to see the latest equipment and talk to exhibitors.

Key Dates

- Abstract submission:
- Notification of acceptance:
- Presentation slides:

August 13th, 2010
September 30th, 2010
October 31st, 2010

Further Information and Submissions

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Visit the NTF web pages at:
<http://www.nordicestforum.org>



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